

FIG 1

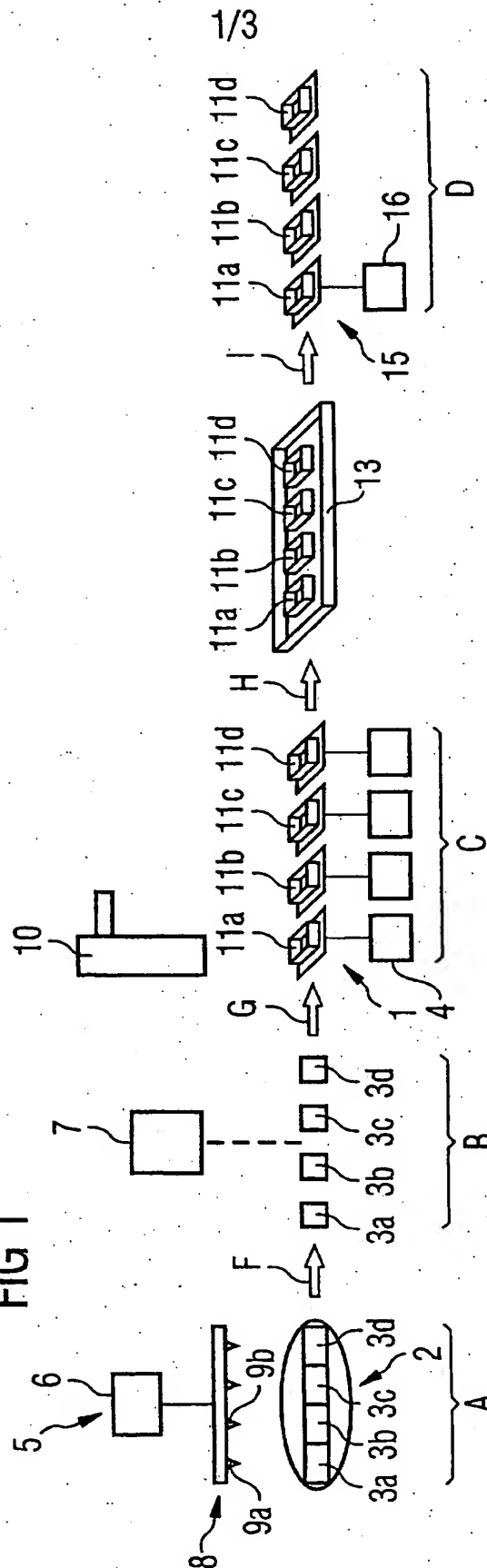
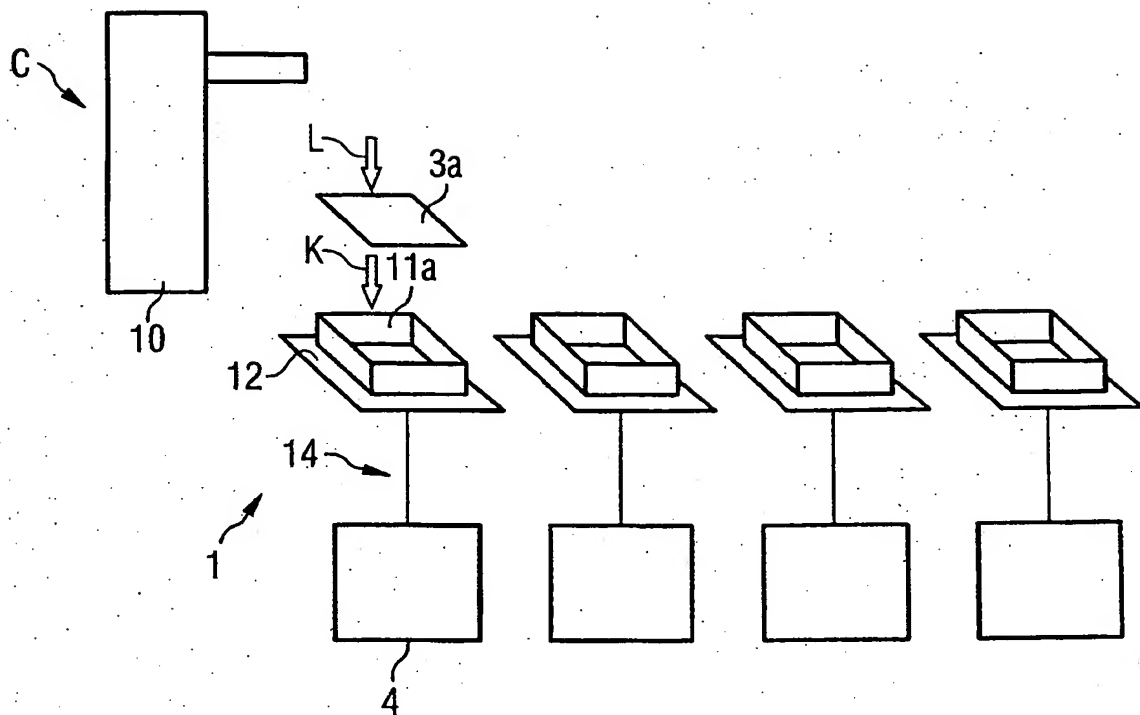


FIG 2



New U.S. Appln.

Docket No.: 543822002400

Inventor: Holger HOPPE

Title: TESTING APPARATUS AND METHOD FOR TESTING
THE CONTACTING BETWEEN A SEMICONDUCTOR
DEVICE AND A CARRIER

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FIG 3

